

Metalenses phase characterization by multidistance phase retrieval





(a) and (b) Optical microscope images depicting the sample with defects and the defect-free sample. (c) and (d) Experimentally measured optical field distributions for the sample with defects and the defect-free sample. Phase distribution, wave aberration, and Zernike expansion coefficients are illustrated for the sample with defects in (e)-(g) and the defect-free sample in (h)-(j). Credit: Bowen Liu et al.



Metalens is a kind of optical metasurface composed of metaatoms for manipulating incoming light's amplitude, phase, and polarization. Unlike traditional refractive lenses, metalens can modulate the wavefront from plane to spherical at an interface. It has garnered widespread attention due to its novel physical properties and promising potential applications.

As a phase-modulated optical functional component, phase distributions are the key parameter of metalens. However, in the optical frequency band, it is difficult to measure the phase distribution directly. Instead of measuring phase, the mainstream measurement methods for characterizing metalens currently involve light field scanning and electron microscopy. However, these methods do not directly provide the phase response of metalens.

In a new paper <u>published</u> in *Light: Science & Applications*, the PBG Group at Fudan University, in collaboration with City University of Hong Kong and Tsinghua University, has a new phase characterization method for metalens based on multi-distance phase retrieval through optical field scanning. This innovative method successfully overcomes the limitations of traditional interferometric techniques, which rely on the coherence length of the light source and the stability of the optical path.

Using this method, the research team quantitatively measured the phase distribution of a near-infrared metalens and, for the first time, successfully observed the phase changes induced by changes in the working medium of metalens.

The multi-distance phase retrieval system can measure the intensity distribution by translating the entire optical path. By measuring a series of equally spaced optical field intensity distributions starting from the sample surface and inputting them into an iterative algorithm, we can determine the phase distribution of the sample. This method is suitable



for phase characterization of metalens with different design principles, operating wavelengths, and working media.



(a) Phase distribution,(b) unwrapped phase distribution at the center of the sample, and (c) wave aberration of metalens working in ethanol (left) and air (right). Credit: Bowen Liu et al

"Compared to other phase characterization methods for metalens, our system has the following advantages: Unlike off-axis digital holography, our system is free from the constraints of the coherence length of the light source.

"Additionally, our system does not require the construction of complex optical paths, making it more cost-effective. Compared to wavefront sensors, our system does not need to introduce a diffraction grating for splitting light, resulting in higher energy utilization and avoiding the influence of the grating's morphology," the researchers explain.

"Using the aforementioned method, we conducted phase measurements and wavefront error analysis on a set of near-infrared metalenses operating at a wavelength of 1560 nm. One sample exhibited defects



during processing and storage, specifically manifesting as dirt and scratches on the surface. After measuring the phase and calculating the wavefront error, we determined the impact of the defects on the phase and computed the corresponding Zernike coefficients."

We measured the phase distribution of the same sample when immersed in both air and ethanol. Due to the change in the working medium, the phase distribution of the metalens exhibited significant alterations.

Compared to its phase distribution in air, the sample displayed noticeable phase jumps when immersed in ethanol. This indicates that the phase modulation of some meta-atoms changes in different media.

This is the first time that changes in metalens phase modulation due to variations in the working environment have been observed. This discovery provides a new perspective for understanding the optical behavior of metalenses in different media and offers important insights for the future design and application of metalenses.

More information: Bowen Liu et al, Metalenses phase characterization by multi-distance phase retrieval, *Light: Science & Applications* (2024). DOI: 10.1038/s41377-024-01530-1

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